



# **Applications**

- · Military radar
- Civilian radar
- · Professional and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers



• Frequency: DC to 6 GHz

• Output Power (P<sub>3dB</sub>): 25 W at 5.6 GHz

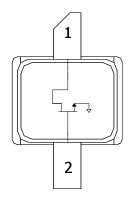
• Linear Gain: >14 dB at 5.6 GHz

Operating Voltage: 28 V

Low thermal resistance package



# **Functional Block Diagram**



# **General Description**

The TriQuint T2G6003028-FS is a 30W (P3dB) discrete GaN on SiC HEMT which operates from DC to 6 GHz. The device is constructed with TriQuint's proven TQGaN25 process, which features advanced field plate techniques to optimize power and efficiency at high drain bias operating conditions. This optimization can potentially lower system costs in terms of fewer amplifier line-ups and lower thermal management costs.

Lead-free and ROHS compliant

Evaluation boards are available upon request.

# **Pin Configuration**

Pin No.	Label
1	V <sub>D</sub> / RF OUT
2	V <sub>G</sub> / RF IN
Flange	Source

# **Ordering Information**

Part	<b>ECCN</b>	Description
T2G6003028-FS	EAR99	Packaged part Flangeless
T2G6003028-FS- EVB1	EAR99	5.4 – 5.9 GHz Evaluation Board
T2G6003028-FS- EVB2	EAR99	1.3 – 1.9 GHz Evaluation Board



# 30W, 28V DC – 6 GHz, GaN RF Power Transistor

# **Absolute Maximum Ratings**

Parameter	Value
Breakdown Voltage (BV <sub>DG</sub> )	100 V
Gate Voltage Range (V <sub>G</sub> )	-7 to 0 V
Drain Current (I <sub>D</sub> )	5.5 A
Gate Current (I <sub>G</sub> )	-10 to 28 mA
Power Dissipation (P <sub>D</sub> )	47.5 W
RF Input Power, CW, T = 25 °C (P <sub>IN</sub> )	40 dBm
Channel Temperature (T <sub>CH</sub> )	275 ℃
Mounting Temperature (30 Seconds)	320 ℃
Storage Temperature	-40 to 150 ℃

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

# **Recommended Operating Conditions**

Parameter	Value
Drain Voltage (V <sub>D</sub> )	28 V (Typ.)
Drain Quiescent Current (I <sub>DQ</sub> )	200 mA (Typ.)
Peak Drain Current (I <sub>D</sub> )	1.7 A (Typ.)
Gate Voltage (V <sub>G</sub> )	-3.0 V (Typ.)
Channel Temperature (T <sub>CH</sub> )	225 °C (Max)
Power Dissipation, CW (P <sub>D</sub> )	35 W (Max)
Power Dissipation, Pulse (P <sub>D</sub> )	40 W (Max)

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

# RF Characterization – Load Pull Performance at 3.0 GHz (1)

Test conditions unless otherwise noted:  $T_A = 25$  °C,  $V_D = 28$  V,  $I_{DQ} = 200$  mA

<b>Symbol</b>	Parameter	Min	Typical	Max	Units
G <sub>LIN</sub>	Linear Gain		14.7		dB
P <sub>3dB</sub>	Output Power at 3 dB Gain Compression		37.7		W
DE <sub>3dB</sub>	Drain Efficiency at 3 dB Gain Compression		77.7		%
PAE <sub>3dB</sub>	Power-Added Efficiency at 3 dB Gain		72.4		%
G <sub>3dB</sub>	Gain at 3 dB Compression		11.7		dB

Notes:

# RF Characterization – Load Pull Performance at 6.0 GHz (1)

Test conditions unless otherwise noted:  $T_A = 25$  °C,  $V_D = 28$  V,  $I_{DQ} = 200$  mA

Symbol	Parameter	Min	Typical	Max	Units
$G_{LIN}$	Linear Gain		15.9		dB
P <sub>3dB</sub>	Output Power at 3 dB Gain Compression		37.0		W
DE <sub>3dB</sub>	Drain Efficiency at 3 dB Gain Compression		63.3		%
PAE <sub>3dB</sub>	Power-Added Efficiency at 3 dB Gain		60.0		%
G <sub>3dB</sub>	Gain at 3 dB Compression		12.9		dB

Notes:

<sup>1.</sup>  $V_{DS} = 28 \text{ V}$ ,  $I_{DQ} = 200 \text{ mA}$ ; Pulse:  $100 \mu \text{s}$ , 20 %

<sup>1.</sup>  $V_{DS} = 28 \text{ V}$ ,  $I_{DQ} = 200 \text{ mA}$ ; Pulse:  $100 \mu s$ , 20%



# RF Characterization – Performance at 5.6 GHz (1, 2)

Test conditions unless otherwise noted: T<sub>A</sub> = 25 °C, V<sub>D</sub> = 28 V, I<sub>DQ</sub> = 200 mA

<b>Symbol</b>	Parameter	Min	Typical	Max	Units
G <sub>LIN</sub>	Linear Gain		14.6		dB
P <sub>3dB</sub>	Output Power at 3 dB Gain Compression		25.5		W
DE <sub>3dB</sub>	Drain Efficiency at 3 dB Gain Compression		50.0		%
G <sub>3dB</sub>	Gain at 3 dB Compression		11.6		dB

### Notes:

- 1. Performance at 5.6 GHz in the 5.4 to 5.9 GHz Evaluation Board
- 2.  $V_{DS} = 28 \text{ V}$ ,  $I_{DQ} = 200 \text{ mA}$ ; Pulse:  $100 \mu s$ , 20 %

# RF Characterization – Narrow Band Performance at 5.6 GHz (1)

Test conditions unless otherwise noted:  $T_A = 25$  °C,  $V_D = 28$  V,  $I_{DQ} = 200$  mA

Symbol	Parameter	Typical	
VSWR	Impedance Mismatch Ruggedness	10:1	

### Notes:

1.  $V_{DS} = 28 \text{ V}$ ,  $I_{DQ} = 200 \text{ mA}$ , CW at  $P_{1dB}$ 



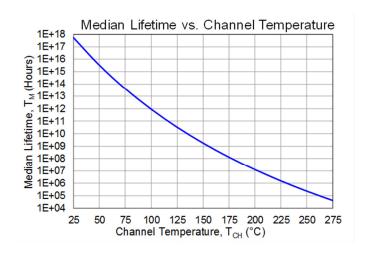
# Thermal and Reliability Information

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ <sub>JC</sub> )	DC at 85 ℃ Case	4.0	ºC/W
Channel Temperature (T <sub>CH</sub> )	DC at 65 C Case	225	℃

Notes:

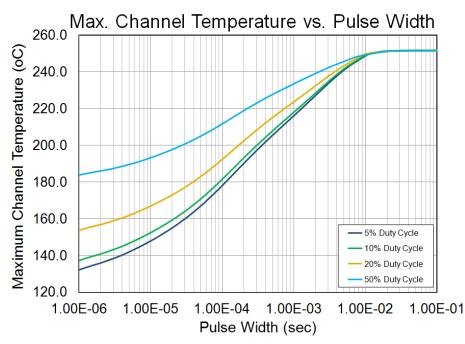
Thermal resistance measured to bottom of package, CW.

# **Median Lifetime**



# **Maximum Channel Temperature**

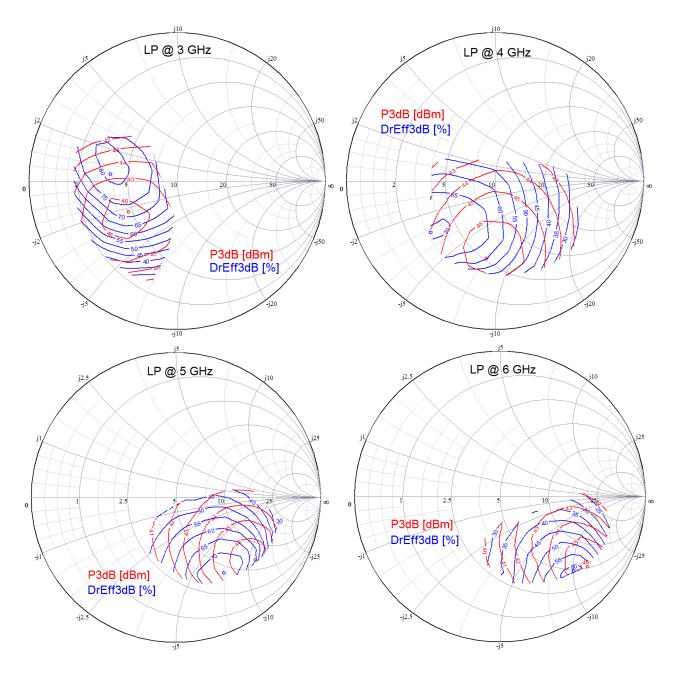
 $T_{BASE} = 85 \,^{\circ}\text{C}, P_D = 40 \text{ W}$ 



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# Load Pull Smith Charts (1, 2)

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

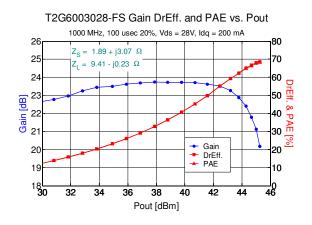


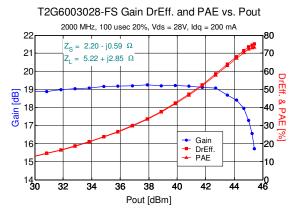
## Notes:

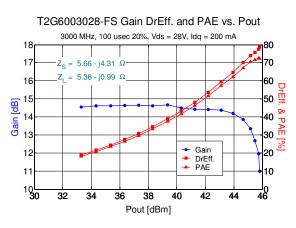
- 1. Test Conditions:  $V_{DS} = 28 \text{ V}$ ,  $I_{DQ} = 200 \text{ mA}$
- 2. Test Signal: Pulse Width = 100 μsec, Duty Cycle = 20%

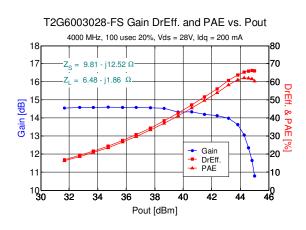
## **Typical Performance**

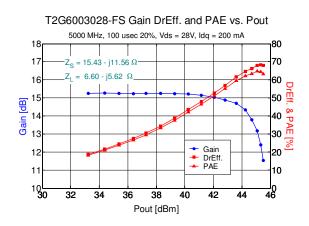
Performance is based on compromised impedance point and measured at DUT reference plane.

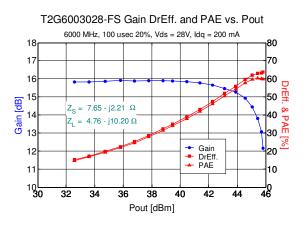






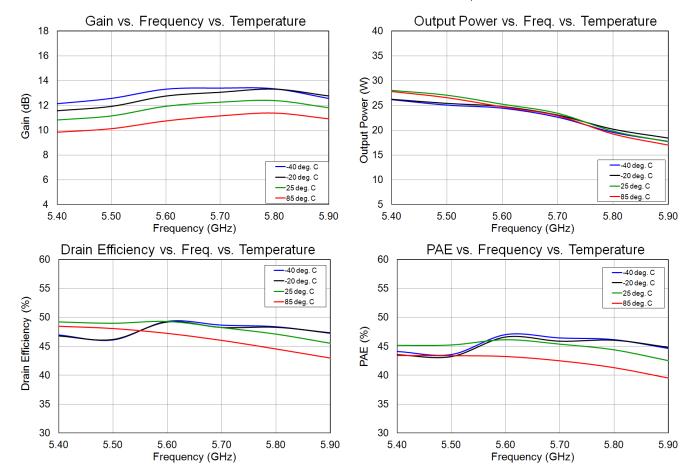






# Performance Over Temperature (1, 2)

Performance measured in TriQuint's 5.4 GHz to 5.9 GHz Evaluation Board at 3 dB compression.

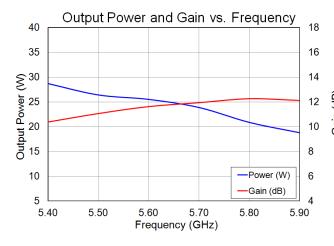


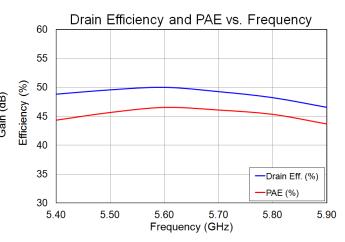
## Notes:

- 1. Test Conditions:  $V_{DS} = 28 \text{ V}$ ,  $I_{DQ} = 200 \text{ mA}$
- 2. Test Signal: Pulse Width = 100 μs, Duty Cycle = 20%

# Evaluation Board Performance (1, 2)

Performance at 3 dB Compression

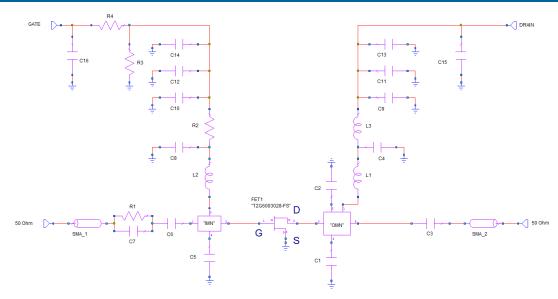




### Notes:

- 1. Test Conditions:  $V_{DS} = 28 \text{ V}$ ,  $I_{DQ} = 200 \text{ mA}$
- 2. Test Signal: Pulse Width = 100 μs, Duty Cycle = 20 %

# **Application Circuit**



# **Bias-up Procedure**

Set gate voltage (V<sub>G</sub>) to -5.0V

Set drain voltage (VD) to 28 V

Slowly increase V<sub>G</sub> until quiescent I<sub>D</sub> is 200 mA.

Apply RF signal

## **Bias-down Procedure**

Turn off RF signal

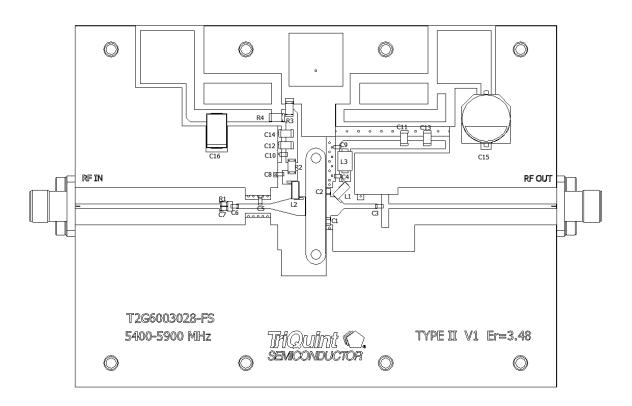
Turn off V<sub>D</sub> and wait 1 second to allow drain capacitor dissipation

Turn off V<sub>G</sub>



# **Evaluation Board Layout**

Top RF layer is 0.020" thick Rogers RO4350B,  $\varepsilon_r = 3.48$ . The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances.



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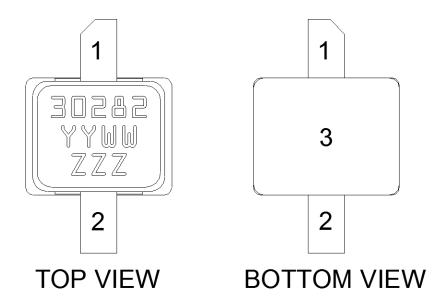
Reference Design	Value	Qty	Manufacturer	Part Number
C1	0.3 pF	1	ATC	ATC600S0R3
C2	0.2 pF	1	ATC	ATC600S0R2
L1, L2	8.8 NH	2	COILCRAFT	1606-8
C3, C4, C6, C7, C8	3 pF	5	ATC	ATC600S3R0
C5	0.4 pF	1	ATC	ATC600S0R5
R1	97.6 Ohms	1	Venkel	CR0604-16w-97R6FT
R2	4.7 Ohms	1	Newark	37C0064
R3	330 Ohms	1	Newark	TNPW1206330RBT9ET1-E3
R4	50 Ohms	1	ATC	CRCW120651R0FKEA
C9, C10	220 pF	2	AVX	AVX06035C22KAT2A
C11, C12	2200 pF	2	Vitramon	VJ1206Y222KXA
C13, C14	22000 pF	2	Vitramon	VJ1206Y223KXA
C15	220 uF	1	United Chemi-Con	EMVY500ADA221MJA0G
C16	1.0 uF	1	Allied	541-1231
L3	48 Ohm	1	Ferrite, Laird Tech.	28F0121-0SR-10

Datasheet: Rev A 12-30-13 © 2013 TriQuint

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# **Pin Layout**



### Note:

The T2G6003028-FS will be marked with the "30282" designator and a lot code marked below the part designator. The "YY" represents the last two digits of the calendar year the part was manufactured, the "WW" is the work week of the assembly lot start, and the "ZZZ" is an auto-generated number.

# **Pin Description**

Pin	Symbol	Description
1	V <sub>D</sub> / RF OUT	Drain voltage / RF Output matched to 50 ohms; see EVB Layout on page 9 as an example.
2	V <sub>G</sub> / RF IN	Gate voltage / RF Input matched to 50 ohms; see EVB Layout on page 9 as an example.
3	Flange	Source connected to ground; see EVB Layout on page 9 as an example.

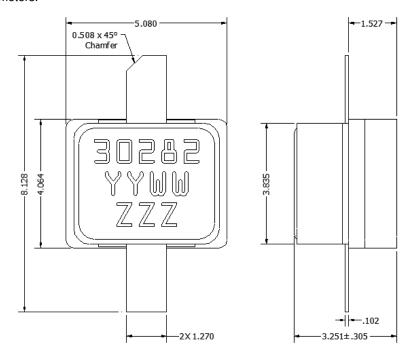
## Notes:

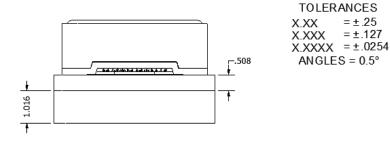
Thermal resistance measured to bottom of package



# **Mechanical Information**

All dimensions are in millimeters.



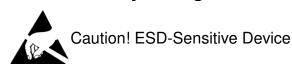


## Note:

This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free (maximum 260 ℃ reflow temperature) and tin-lead (maximum 245 ℃ reflow temperature) soldering processes.

# **Product Compliance Information**

## **ESD Sensitivity Ratings**



ESD Rating: Class 1A

Value: Passes ≥ 250 V to < 500 V max. Test: Human Body Model (HBM) JEDEC Standard JESD22-A114 Standard:

## MSL Rating

Level 3 at +260 °C convection reflow The part is rated Moisture Sensitivity Level 3 at 260 ℃ per JEDEC standard IPC/JEDEC J-STD-020.

## **Solderability**

Compatible with the latest version of J-STD-020, Lead free solder, 260° C

# **RoHs Compliance**

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

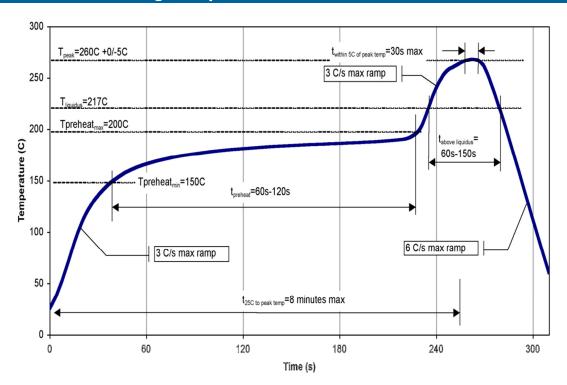
This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A ( $C_{15}H_{12}Br_4O_2$ ) Free
- **PFOS Free**
- SVHC Free

## **ECCN**

US Department of Commerce EAR99

# **Recommended Soldering Temperature Profile**





# T2G6003028-FS

## **Contact Information**

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about TriQuint:

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For technical questions and application information: Email: info-products@triquint.com

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